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### Understanding [Embedded - CPLDs \(Complex Programmable Logic Devices\)](#)

Embedded - CPLDs, or Complex Programmable Logic Devices, are highly versatile digital logic devices used in electronic systems. These programmable components are designed to perform complex logical operations and can be customized for specific applications. Unlike fixed-function ICs, CPLDs offer the flexibility to reprogram their configuration, making them an ideal choice for various embedded systems. They consist of a set of logic gates and programmable interconnects, allowing designers to implement complex logic circuits without needing custom hardware.

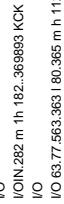
### Applications of Embedded - CPLDs

#### Details

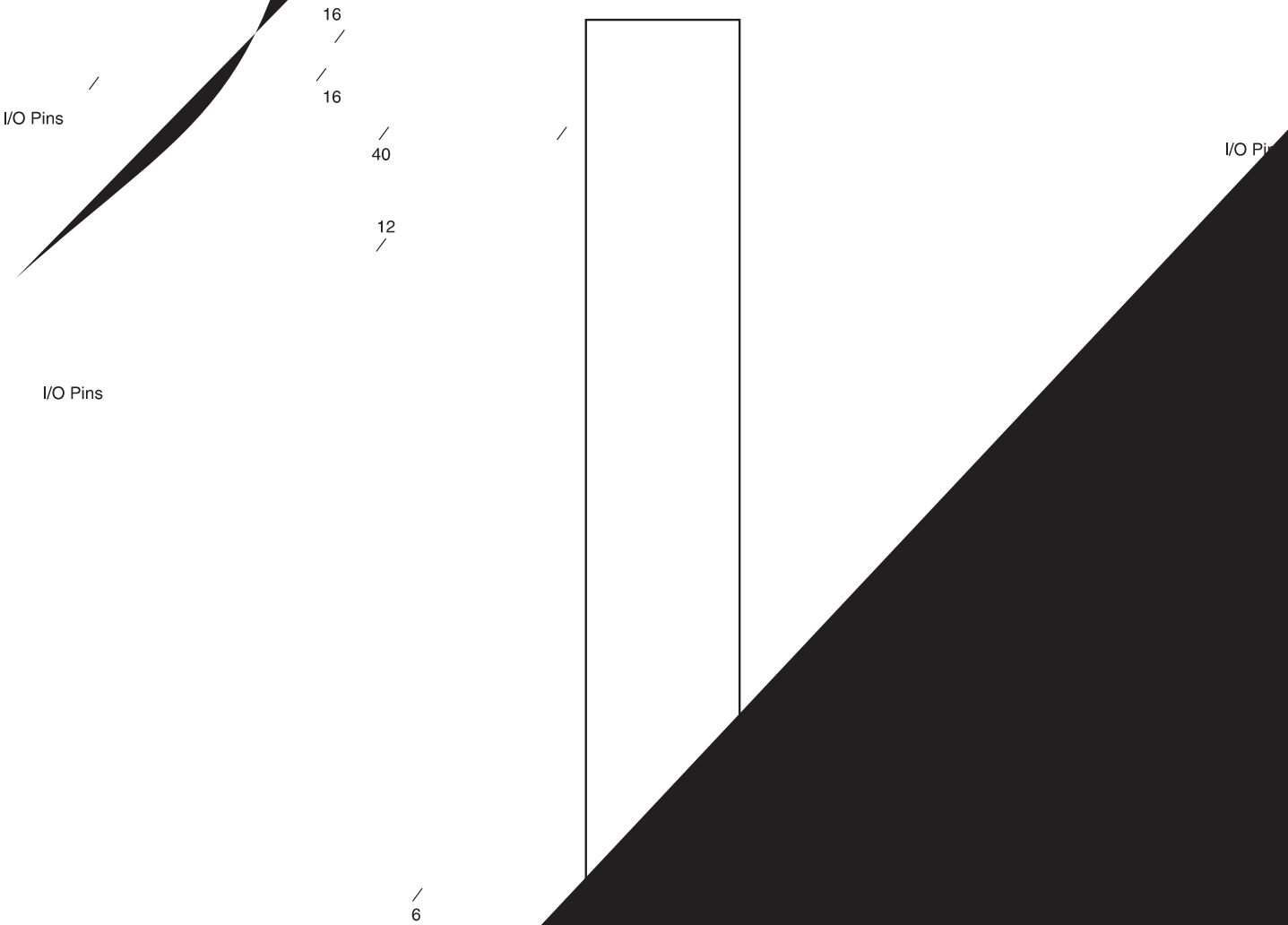
|                                 |   |
|---------------------------------|---|
| Product Status                  | Obsolete  |
| Programmable Type               | In System Programmable (min 10K program/erase cycles)   |
| Delay Time tpd(1) Max           | 20 ns   |
| Voltage Supply - Internal       | 4.75V ~ 5.25V   |
| Number of Logic Elements/Blocks | -   |
| Number of Macrocells            | 128   |
| Number of Gates                 | -   |
| Number of I/O                   | 80  |
| Operating Temperature           | 0°C ~ 70°C (TA)   |
| Mounting Type                   | Surface Mount   |
| Package / Case                  | 100-TQFP  |
| Supplier Device Package         | 100-TQFP (14x14)  |
| Purchase URL                    | <a href="https://www.e-xfl.com/product-detail/microchip-technology/atf1508asl-20ac100">https://www.e-xfl.com/product-detail/microchip-technology/atf1508asl-20ac100</a> |



I/O  
I/OIN.282 m 1h 182..369893 KCK  
I/O  
I/O 63.77.563.363 | 80.365 m h 11.



Block Diagram





## Description

The ATF1508AS is a high-performance, high-density complex programmable logic device (CPLD) that utilizes Atmel's proven electrically-erasable technology. With 128 logic macrocells and up to 100 inputs, it easily integrates logic from several TTL, SSI, MSI, LSI and classic PLDs. The ATF1508AS's enhanced routing switch matrices increase usable gate count and increase odds of successful pin-locked design modifications.

The ATF1508AS has up to 96 bi-directional I/O pins and four dedicated input pins, depending on the type of device package selected. Each dedicated pin can also serve as a global control signal, register clock, register reset or output enable. Each of these control signals can be selected for use individually within each macrocell.

Each of the 128 macrocells generates a buried feedback that goes to the global bus. Each input and I/O pin also feeds into the global bus. The switch matrix in each logic block then selects 40 individual signals from the global bus. Each macrocell also generates a foldback logic term that goes to a regional bus. Cascade logic between macrocells in the ATF1508AS allows fast, efficient generation of complex logic functions. The ATF1508AS contains eight such logic chains, each capable of creating sum term logic with a fan-in of up to 40 product terms.

The ATF1508AS macrocell, shown in Figure 1, is flexible enough to support highly-complex logic functions operating at high speed. The macrocell consists of five sections: product terms and product term select multiplexer; OR/XOR/CASCADE logic, a flip-flop, output select and enable, and logic array inputs.

Unused macrocells are automatically disabled by the compiler to decrease power consumption. A security fuse, when programmed, protects the contents of the ATF1508AS. Two bytes (16 bits) of User Signature are accessible to the user for purposes such as storing project name, part number, revision or date. The User Signature is accessible regardless of the state of the security fuse.

The ATF1508AS device is an in-system programmable (ISP) device. It uses the industry-standard 4-pin JTAG interface (IEEE Std. 1149.1), and is fully compliant with JTAG's Boundary-scan Description Language (BSDL). ISP allows the device to be programmed without removing it from the printed circuit board. In addition to simplifying the manufacturing flow, ISP also allows design modifications to be made in the field via software.

## Product Terms and Select Mux

Each ATF1508AS macrocell has five product terms. Each product term receives as its inputs all signals from both the global bus and regional bus.

The product term select multiplexer (PTMUX) allocates the five product terms as needed to the macrocell logic gates and control signals. The PTMUX programming is determined by the design compiler, which selects the optimum macrocell configuration.

## OR/XOR/CASCADE Logic

The ATF1508AS's logic structure is designed to efficiently support all types of logic. Within a single macrocell, all the product terms can be routed to the OR gate, creating a 5-input

**Flip-flop**

The ATF1508AS's flip-flop has very flexible data and control functions. The data input can come from either the XOR gate, from a separate product term or directly from the I/O pin. Selecting the separate product term allows creation of a buried registered feedback within a combinatorial output macrocell. (This feature is automatically implemented by the fitter software). In addition to D, T, JK and SR operation, the flip-flop can also be configured as a flow-through latch. In this mode, data passes through when the clock is high and is latched when the clock is low.

The clock itself can be either the Global CLK Signal (GCK) or an individual product term. The flip-flop changes state on the clock's rising edge. When the GCK signal is used as the clock, one of the macrocell product terms can be selected as a clock enable. When the clock enable function is active and the enable signal (product term) is low, all clock edges are ignored. The flip-flop's asynchronous reset signal (AR) can be either the Global Clear (GCLEAR), a product term, or always off. AR can also be a logic OR of GCLEAR with a product term. The asynchronous preset (AP) can be a product term or always off.

**Extra Feedback**

The ATF15xxSE Family macrocell output can be selected as registered or combinatorial. The extra buried feedback signal can be either combinatorial or a registered signal regardless of whether the output is combinatorial or registered. (This enhancement function is automatically implemented by the fitter software.) Feedback of a buried combinatorial output allows the creation of a second latch within a macrocell.

**I/O Control**

The output enable multiplexer (MOE) controls the output enable signal. Each I/O can be individually configured as an input, output or for bi-directional operation. The output enable for each macrocell can be selected from the true or compliment of the two output enable pins, a subset of the I/O pins, or a subset of the I/O macrocells. This selection is automatically done by the fitter software when the I/O is configured as an input, all macrocell resources are still available, including the buried feedback, expander and cascade logic.

**Global Bus/Switch Matrix**

The global bus contains all input and I/O pin signals as well as the buried feedback signal from all 128 macrocells. The switch matrix in each logic block receives as its inputs all signals from the global bus. Under software control, up to 40 of these signals can be selected as inputs to the logic block.

**Foldback Bus**

Each macrocell also generates a foldback product term. This signal goes to the regional bus and is available to 16 macrocells. The foldback is an inverse polarity of one of the macrocell's product terms. The 16 foldback terms in each region allows generation of high fan-in sum terms (up to 21 product terms) with a little additional delay.

**3.3V or 5.0V I/O Operation**

The ATF1508AS device has two sets of  $V_{CC}$  pins viz,  $V_{CCINT}$  and  $V_{CCIO}$ .  $V_{CCINT}$  pins must always be connected to a 5.0V power supply.  $V_{CCINT}$  pins are for input buffers and are "compatible" with both 3.3V and 5.0V inputs.  $V_{CCIO}$  pins are for I/O output drives and can be connected for 3.3/5.0V power supply.

**Open-collector Output Option**

This option enables the device output to provide control signals such as an interrupt that can be asserted by any of the several devices.



**Design  
Software  
Support**

## **ISP Programming Protection**

The ATF1508AS has a special feature that locks the device and prevents the inputs and I/O from driving if the programming process is interrupted for any reason. The inputs and I/O default to high-Z state during such a condition. In addition the pin-keeper option preserves the former state during device programming.

All ATF1508AS devices are initially shipped in the erased state thereby making them ready to use for ISP.

Note: For more information refer to the "Designing for In-System Programmability with Atmel CPLDs" application note.

## **JTAG-BST Overview**

The JTAG boundary-scan testing is controlled by the Test Access Port (TAP) controller in the ATF1508AS. The boundary-scan technique involves the inclusion of a shift-register stage (contained in a boundary-scan cell) adjacent to each component so that signals at component boundaries can be controlled and observed using scan testing principles. Each input pin and I/O pin has its own boundary-scan cell (BSC) in order to support boundary-scan testing. The ATF1508AS does not currently include a Test Reset (TRST) input pin because the TAP controller is automatically reset at power-up. The six JTAG BST modes supported include: SAMPLE/PRELOAD, EXTEST, BYPASS and IDCODE. BST on the ATF1508AS is implemented using the Boundary-scan Definition Language (BSDL) described in the JTAG specification (IEEE Standard 1149.1). Any third-party tool that supports the BSDL format can be used to perform BST on the ATF1508AS.

The ATF1508AS also has the option of using four JTAG-standard I/O pins for In-System programming (ISP). The ATF1508AS is programmable through the four JTAG pins using programming compatible with the IEEE JTAG Standard 1149.1. Programming is performed by using 5V TTL-level programming signals from the JTAG ISP interface. The JTAG feature is a programmable option. If JTAG (BST or ISP) is not needed, then the four JTAG control pins are available as I/O pins.

## **JTAG Boundary-scan Cell (BSC) Testing**

The ATF1508AS contains up to 96 I/O pins and four input pins, depending on the device type and package type selected. Each input pin and I/O pin has its own boundary-scan cell (BSC) in order to support boundary-scan testing as described in detail by IEEE Standard 1149.1. A typical BSC consists of three capture registers or scan registers and up to two update registers. There are two types of BSCs, one for input or I/O pin, and one for the macrocells. The BSCs in the device are chained together through the (BST) capture registers. Input to the capture register chain is fed in from the TDI pin while the output is directed to the TDO pin. Capture registers are used to capture active device data signals, to shift data in and out of the device and to load data into the update registers. Control signals are generated internally by the JTAG TAP controller. The BSC configuration for the input and I/O pins and macrocells are shown below.



## BSC Configuration Pins and Macrocells (Except JTAG TAP Pins)

Dedic

To Internal

D

TDO

TDI  
(From Next Register)

Note: The ATF1508AS has a pull-up option on TMS and TDI pins. This feature is selected as a design option.

## BSC Configuration for Macrocell

## Boundary Scan Definition Language (BSDL) Models for the ATF1508

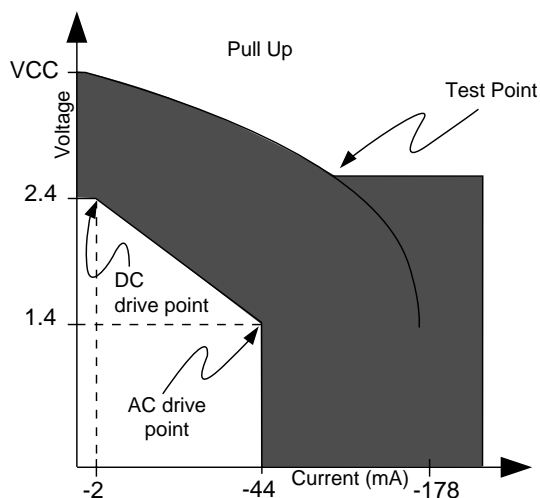
These are now available in all package types via the Atmel Web Site. These models can be used for Boundary-scan Test Operation in the ATF1508AS and have been scheduled to conform to the IEEE 1149.1 standard.



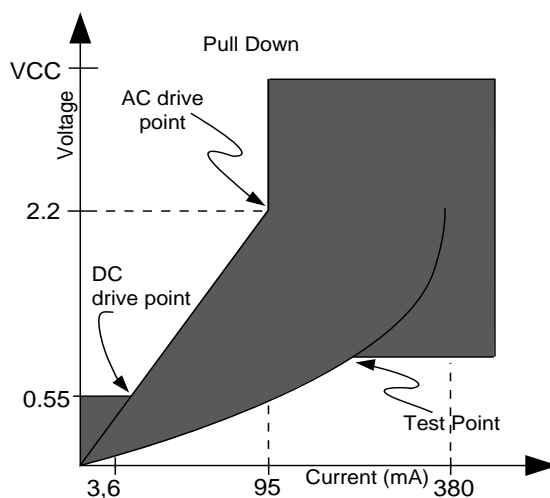
## PCI Compliance

The ATF1508AS also supports the growing need in the industry to support the new Peripheral Component Interconnect (PCI) interface standard in PCI-based designs and specifications. The PCI interface calls for high current drivers, which are much larger than the traditional TTL drivers.

## PCI Voltage-to-current Curves for +5V Signaling in Pull-up Mode



## PCI Voltage-to-current Curves for +5V Signaling in Pull-down Mode



## PCI DC Characteristics

| Symbol      | Parameter                                 | Conditions                           | Min  | Max            | Units   |
|-------------|---|--------------------------------------|------|----------------|---------|
| $V_{CC}$    | Supply Voltage                            |                                      | 4.75 | 5.25           | V       |
| $V_{IH}$    | Input High Voltage                        |                                      | 2.0  | $V_{CC} + 0.5$ | V       |
| $V_{IL}$    | Input Low Voltage                         |                                      | -0.5 | 0.8            | V       |
| $I_{IH}$    | Input High Leakage Current <sup>(1)</sup> | $V_{IN} = 2.7V$                      |      | 70             | $\mu A$ |
| $I_{IL}$    | Input Low Leakage Current <sup>(1)</sup>  | $V_{IN} = 0.5V$                      |      | -70            | $\mu A$ |
| $V_{OH}$    | Output High Voltage                       | $I_{OUT} = -2\text{ mA}$             | 2.4  |                | V       |
| $V_{OL}$    | Output Low Voltage                        | $I_{OUT} = 3\text{ mA}, 6\text{ mA}$ |      | 0.55           | V       |
| $C_{IN}$    | Input Pin Capacitance                     |                                      |      | 10             | pF      |
| $C_{CLK}$   | CLK Pin Capacitance                       |                                      |      | 12             | pF      |
| $C_{IDSEL}$ | IDSEL Pin Capacitance                     |                                      |      | 8              | pF      |
| $L_{PIN}$   | Pin Inductance                            |                                      |      | 20             | nH      |

Note: 1. Leakage current is without pin-keeper off.

## PCI AC Characteristics

| Symbol       | Parameter    | Conditions               | Min                           | Max                       | Units |
|--------------|--------------|--------------------------|-------------------------------|---------------------------|-------|
| $I_{OH(AC)}$ | Switching    | $0 < V_{OUT} \leq 1.4$   | -44                           |                           | mA    |
|              | Current High | $1.4 < V_{OUT} < 2.4$    | $-44 + (V_{OUT} - 1.4)/0.024$ |                           | mA    |
|              |              | $3.1 < V_{OUT} < V_{CC}$ |                               | Equation A <sup>(1)</sup> | mA    |

Notes: 1. Equation A:  $I_{OH} = 11.9 (V_{OUT} - 5.25) * (V_{OUT} + 2.45)$  for  $V_{CC} > V_{OUT} > 3.1V$ .  
2. Equation B:  $I_{OL} = 78.5 * V_{OUT} * (4.4 - V_{OUT})$  for  $0V < V_{OUT} < 0.71V$ .

## Power-down Mode

The ATF1508AS includes two pins for optional pin-controlled power-down feature. When this mode is enabled, the PD pin acts as the power-down pin. When the PD1 and PD2 pin is high, the device supply current is reduced to less than 10 mA. During power-down, all output data and internal logic states are latched and held. Therefore, all registered and combinatorial output data remain valid. Any outputs that were in a high-Z state at the onset will remain at high-Z. During power-down, all input signals except the power-down pin are blocked. Input and I/O hold latches remain active to ensure that pins do not float to indeterminate levels, further reducing system power. The power-down pin feature is enabled in the logic design file. Designs using either power-down pin may not use the PD pin logic array input. However, buried logic resources in this macrocell may still be used.

## Power-down AC Characteristics<sup>(1)(2)</sup>

| Symbol     | Parameter                                     | -7  |     | -10 |     | -15 |     | -20 |     | -25 |     | Units |
|------------|---|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|-------|
|            |   | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max |       |
| $t_{IVDH}$ | Valid I, I/O before PD High                   | 7   |     | 10  |     | 15  |     | 20  |     | 25  |     | ns    |
| $t_{GVDH}$ | Valid OE <sup>(2)</sup> before PD High        | 7   |     | 10  |     | 15  |     | 20  |     | 25  |     | ns    |
| $t_{CVDH}$ | Valid Clock <sup>(2)</sup> before PD High     | 7   |     | 10  |     | 15  |     | 20  |     | 25  |     | ns    |
| $t_{DHIX}$ | I, I/O Don't Care after PD High               |     | 12  |     | 15  |     | 25  |     | 30  |     | 35  | ns    |
| $t_{DHGX}$ | OE <sup>(2)</sup> Don't Care after PD High    |     | 12  |     | 15  |     | 25  |     | 30  |     | 35  | ns    |
| $t_{DHCX}$ | Clock <sup>(2)</sup> Don't Care after PD High |     | 12  |     | 15  |     | 25  |     | 30  |     | 35  | ns    |
| $t_{DLIV}$ | PD Low to Valid I, I/O                        |     | 1   |     | 1   |     | 1   |     | 1   |     | 1   | μs    |
| $t_{DLGV}$ | PD Low to Valid OE (Pin or Term)              |     | 1   |     | 1   |     | 1   |     | 1   |     | 1   | μs    |
| $t_{DLCV}$ | PD Low to Valid Clock (Pin or Term)           |     | 1   |     | 1   |     | 1   |     | 1   |     | 1   | μs    |
| $t_{DLOV}$ | PD Low to Valid Output                        |     | 1   |     | 1   |     | 1   |     | 1   |     | 1   | μs    |

- Notes: 1. For slow slew outputs, add  $t_{SSO}$ .  
2. Pin or product term.

## Absolute Maximum Ratings\*

|  |                                |
|--|--------------------------------|
| Temperature Under Bias.....  | -40°C to +85°C                 |
| Storage Temperature .....  | -65°C to +150°C                |
| Voltage on Any Pin with<br>Respect to Ground .....                         | -2.0V to +7.0V <sup>(1)</sup>  |
| Voltage on Input Pins<br>with Respect to Ground<br>During Programming..... | -2.0V to +14.0V <sup>(1)</sup> |
| Programming Voltage with<br>Respect to Ground .....                        | -2.0V to +14.0V <sup>(1)</sup> |

\*NOTICE: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

- Note: 1. Minimum voltage is -0.6V DC, which may undershoot to -2.0V for pulses of less than 20 ns. Maximum output pin voltage is  $V_{CC} + 0.75V$  DC, which may overshoot to 7.0V for pulses of less than 20 ns.

## DC and AC Operating Conditions

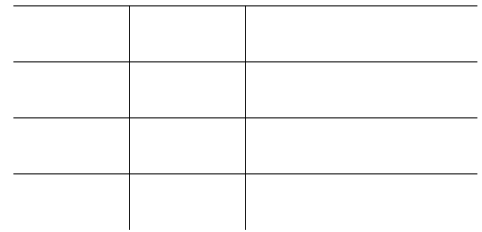
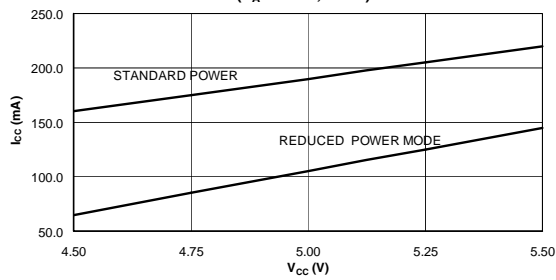
|   | Commercial  | Industrial   |
|---|-------------|--------------|
| Operating Temperature (Ambient)                           | 0°C - 70°C  | -40°C - 85°C |
| V <sub>CCINT</sub> or V <sub>CCIO</sub> (5V) Power Supply | 5V ± 5%     | 5V ± 10%     |
| V <sub>CCIO</sub> (3.3V) Power Supply                     | 2.7V - 3.6V | 2.7V - 3.6V  |

## DC Characteristics<sup>(1)</sup>

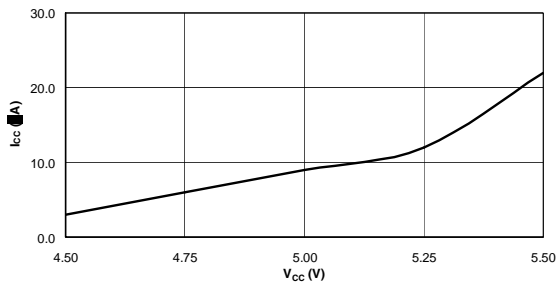
| Symbol                          | Parameter                             | Condition  |           |      | Min  | Typ | Max                     | Units |
|---------------------------------|---------------------------------------|--|-----------|------|------|-----|-------------------------|-------|
| I <sub>IL</sub>                 | Input or I/O Low Leakage Current      | V <sub>IN</sub> = V <sub>CC</sub>  |           |      |      | -2  | -10                     | μA    |
| I <sub>IH</sub>                 | Input or I/O High Leakage Current     |  |           |      |      | 2   | 10                      | μA    |
| I <sub>OZ</sub>                 | Tri-state Output Off-state Current    | V <sub>O</sub> = V <sub>CC</sub> or GND  |           |      | -40  |     | 40                      | μA    |
| I <sub>CC1</sub>                | Power Supply Current, Standby         | V <sub>CC</sub> = Max<br>V <sub>IN</sub> = 0, V <sub>CC</sub>  | Std Mode  | Com. |      | 160 |                         | mA    |
|                                 |                                       |  |           | Ind. |      | 180 |                         | mA    |
|                                 |                                       |  | “L” Mode  | Com. |      | 10  |                         | μA    |
|                                 |                                       |  |           | Ind. |      | 10  |                         | μA    |
| I <sub>CC2</sub>                | Power Supply Current, Power-down Mode | V <sub>CC</sub> = Max<br>V <sub>IN</sub> = 0, V <sub>CC</sub>  | “PD” Mode |      |      | 1   | 10                      | mA    |
| I <sub>CC3</sub> <sup>(2)</sup> | Reduced-power Mode Supply Current     | V <sub>CC</sub> = Max<br>V <sub>IN</sub> = 0, V <sub>CC</sub>  | Std Mode  | Com. |      | 65  |                         | mA    |
|                                 |                                       |  |           | Ind. |      | 85  |                         | mA    |
| V <sub>CCIO</sub>               | Supply Voltage                        | 5.0V Device Output   | Com.      |      | 4.75 |     | 5.25                    | V     |
|                                 |                                       |  | Ind.      |      | 4.5  |     | 5.5                     | V     |
| V <sub>CCIO</sub>               | Supply Voltage                        | 3.3V Device Output   |           |      | 3.0  |     | 3.6                     | V     |
| V <sub>IL</sub>                 | Input Low Voltage                     |  |           |      | -0.3 |     | 0.8                     | V     |
| V <sub>IH</sub>                 | Input High Voltage                    |  |           |      | 2.0  |     | V <sub>CCIO</sub> + 0.3 | V     |
| V <sub>OL</sub>                 | Output Low Voltage (TTL)              | V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub><br>V <sub>CCIO</sub> = MIN, I <sub>OL</sub> = 12 mA   | Com.      |      |      |     | 0.45                    | V     |
|                                 |                                       |  | Ind.      |      |      |     | 0.45                    | V     |
|                                 | Output Low Voltage (CMOS)             | V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub><br>V <sub>CC</sub> = MIN, I <sub>OL</sub> = 0.1 mA    | Com.      |      |      |     | 0.2                     | V     |
|                                 |                                       |  | Ind.      |      |      |     | 0.2                     | V     |
| V <sub>OH</sub>                 | Output High Voltage (TTL)             | V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub><br>V <sub>CCIO</sub> = MIN, I <sub>OH</sub> = -4.0 mA |           |      | 2.4  |     |                         | V     |

Notes: 1. Not more than one output at a time should be shorted. Duration of short circuit test should not exceed 30 sec.  
2. I<sub>CC3</sub> refers to the current in the reduced-power mode when macrocell reduced-power is turned ON.

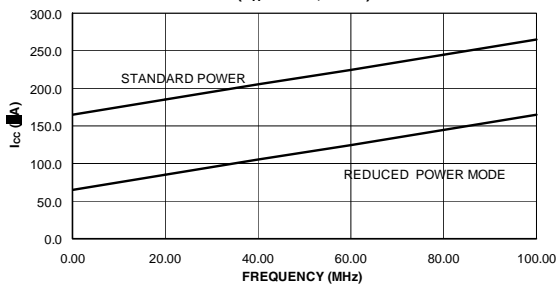
**SUPPLY CURRENT VS. SUPPLY VOLTAGE**  
( $T_A = 25^\circ\text{C}$ ,  $F = 0$ )



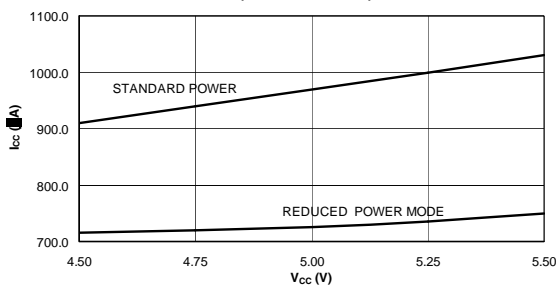
**SUPPLY CURRENT VS. SUPPLY VOLTAGE**  
**LOW-POWER ("L") VERSION**  
( $T_A = 25^\circ\text{C}$ ,  $F = 0$ )

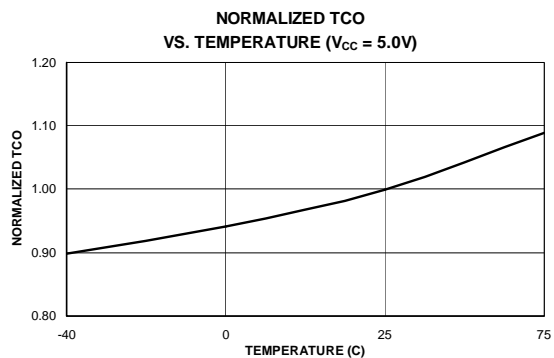
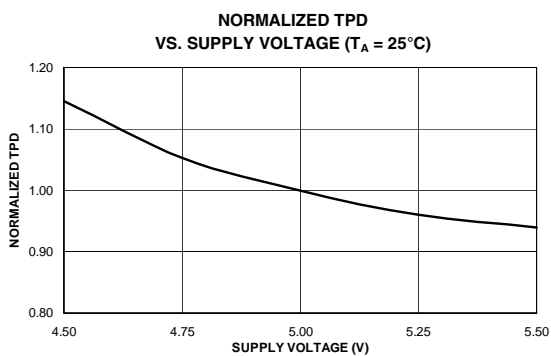
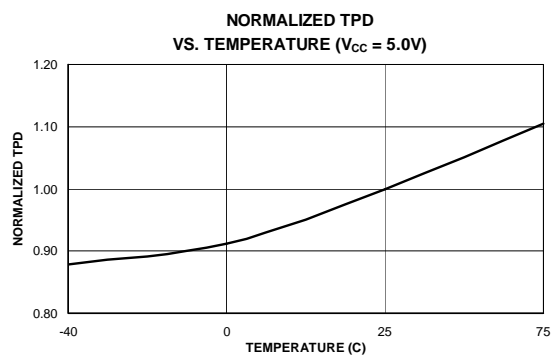
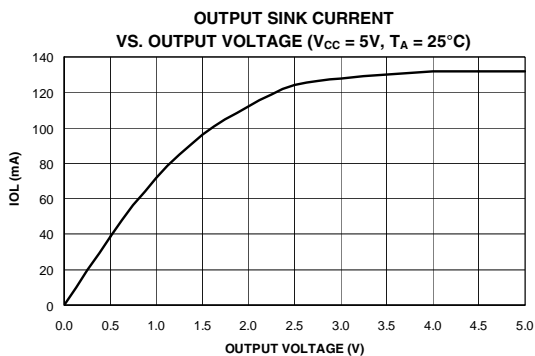
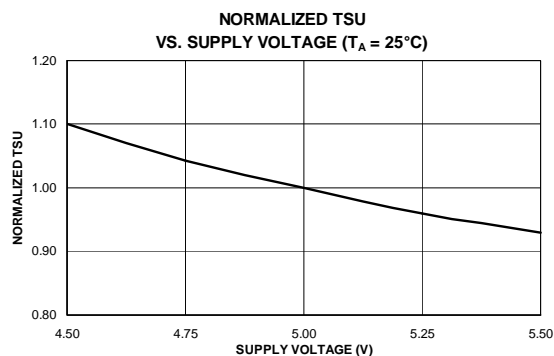
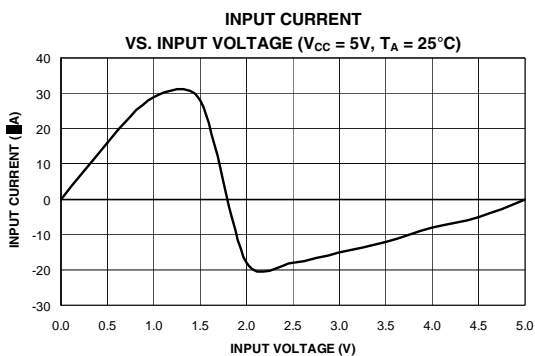
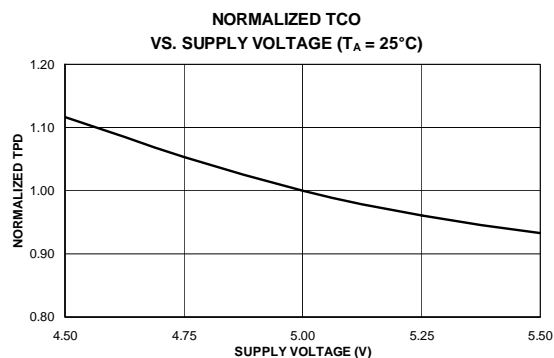
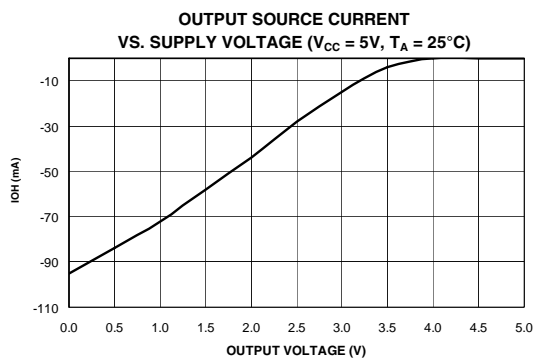


**SUPPLY CURRENT VS. FREQUENCY**  
**STANDARD POWER**  
( $T_A = 25^\circ\text{C}$ ,  $F = 0$ )



**SUPPLY CURRENT VS. SUPPLY VOLTAGE**  
**PIN-CONTROLLED POWER-DOWN MODE**  
( $T_A = 25^\circ\text{C}$ ,  $F = 0$ )





## AC Characteristics (Continued)<sup>(1)</sup>

| Symbol     | Parameter  | -7  |     | -10 |     | -15 |     | -20 |     | -25 |     | Units |
|------------|--|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|-------|
|            |  | Min | Max | Min | Max | Min | Max | Min | Max | Min | Max |       |
| $t_{OD2}$  | Output Buffer and Pad Delay<br>(Slow slew rate = OFF;<br>$V_{CCIO} = 3.3V$ ; $C_L = 35$ pF)        |     | 2.5 |     | 2.0 |     | 5   |     | 6   |     | 7   | ns    |
| $t_{OD3}$  | Output Buffer and Pad Delay<br>(Slow slew rate = ON;<br>$V_{CCIO} = 5V$ or $3.3V$ ; $C_L = 35$ pF) |     | 5   |     | 5.5 |     | 8   |     | 10  |     | 12  | ns    |
| $t_{ZX1}$  | Output Buffer Enable Delay<br>(Slow slew rate = OFF;<br>$V_{CCIO} = 5.0V$ ; $C_L = 35$ pF)         |     | 4.0 |     | 5.0 |     | 7   |     | 9   |     | 10  | ns    |
| $t_{ZX2}$  | Output Buffer Enable Delay<br>(Slow slew rate = OFF;<br>$V_{CCIO} = 3.3V$ ; $C_L = 35$ pF)         |     | 4.5 |     | 5.5 |     | 7   |     | 9   |     | 10  | ns    |
| $t_{ZX3}$  | Output Buffer Enable Delay<br>(Slow slew rate = ON;<br>$V_{CCIO} = 5.0V/3.3V$ ; $C_L = 35$ pF)     |     | 9   |     | 9   |     | 10  |     | 11  |     | 12  | ns    |
| $t_{XZ}$   | Output Buffer Disable Delay<br>( $C_L = 5$ pF)   |     | 4   |     | 5   |     | 6   |     | 7   |     | 8   | ns    |
| $t_{SU}$   | Register Setup Time  | 3   |     | 2   |     | 4   |     | 5   |     | 6   |     | ns    |
| $t_H$      | Register Hold Time   | 2   |     | 3   |     | 4   |     | 5   |     | 6   |     | ns    |
| $t_{FSU}$  | Register Setup Time of Fast Input  | 3   |     | 3   |     | 2   |     | 2   |     | 3   |     | ns    |
| $t_{FH}$   | Register Hold Time of Fast Input   | 0.5 |     | 0.5 |     | 2   |     | 2   |     | 2.5 |     | ns    |
| $t_{RD}$   | Register Delay   |     | 1   |     | 2   |     | 1   |     | 2   |     | 2   | ns    |
| $t_{COMB}$ | Combinatorial Delay  |     | 1   |     | 2   |     | 1   |     | 2   |     | 2   | ns    |
| $t_{IC}$   | Array Clock Delay  |     | 3   |     | 5   |     | 6   |     | 7   |     | 8   | ns    |
| $t_{EN}$   | Register Enable Time   |     | 3   |     | 5   |     | 6   |     | 7   |     | 8   | ns    |
| $t_{GLOB}$ | Global Control Delay   |     | 1   |     | 1   |     | 1   |     | 1   |     | 1   | ns    |
| $t_{PRE}$  | Register Preset Time   |     | 2   |     | 3   |     | 4   |     | 5   |     | 6   | ns    |
| $t_{CLR}$  | Register Clear Time  |     | 2   |     | 3   |     | 4   |     | 5   |     | 6   | ns    |
| $t_{UIM}$  | Switch Matrix Delay  |     | 1   |     | 1   |     | 2   |     | 2   |     | 2   | ns    |
| $t_{RPA}$  | Reduced-power Adder <sup>(2)</sup>   |     | 10  |     | 11  |     | 13  |     | 14  |     | 15  | ns    |

- Notes: 1. See ordering information for valid part numbers.  
2. The  $t_{RPA}$  parameter must be added to the  $t_{LAD}$ ,  $t_{LAC}$ ,  $t_{TIC}$ ,  $t_{ACL}$ , and  $t_{SEXP}$  parameters for macrocells running in the reduced-power mode.

## ATF1508AS Dedicated Pinouts

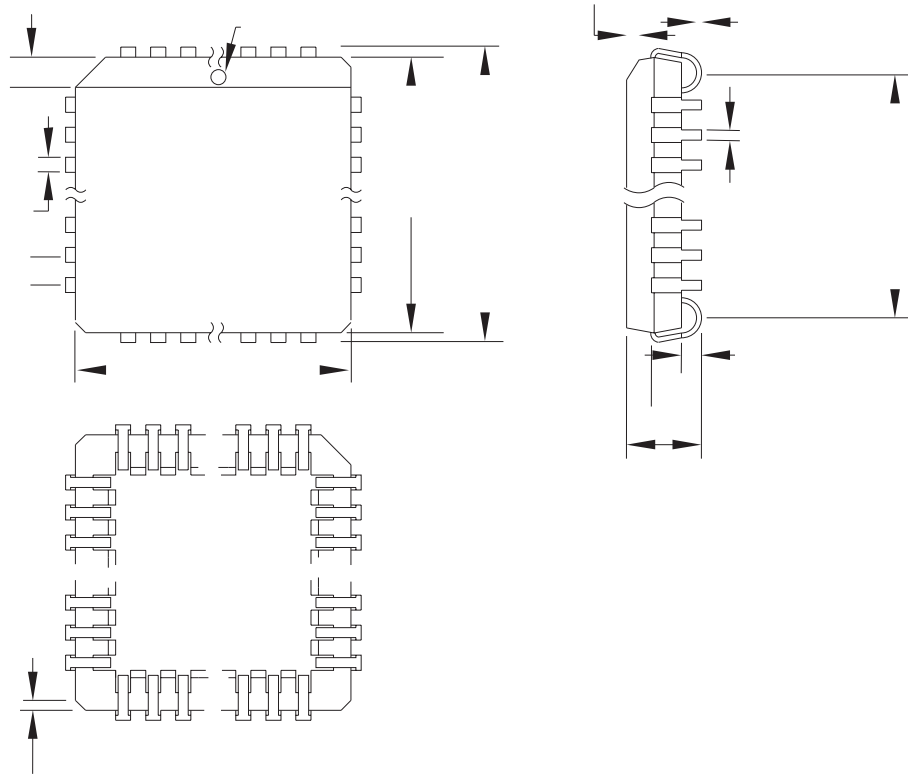
| Dedicated Pin    | 84-lead J-lead             | 100-lead PQFP               | 100-lead TQFP               | 160-lead PQFP   |
|------------------|----------------------------|-----------------------------|-----------------------------|---|
| INPUT/OE2/GCLK2  | 2                          | 92                          | 90                          | 142   |
| INPUT/GCLR       | 1                          | 91                          | 89                          | 141   |
| INPUT/OE1        | 84                         | 90                          | 88                          | 140   |
| INPUT/GCLK1      | 83                         | 89                          | 87                          | 139   |
| I/O /GCLK3       | 81                         | 87                          | 85                          | 137   |
| I/O / PD (1, 2)  | 12,45                      | 3,43                        | 1,41                        | 63,159  |
| I/O / TDI(JTAG)  | 14                         | 6                           | 4                           | 9   |
| I/O / TMS(JTAG)  | 23                         | 17                          | 15                          | 22  |
| I/O / TCK(JTAG)  | 62                         | 64                          | 62                          | 99  |
| I/O / TDO(JTAG)  | 71                         | 75                          | 73                          | 112   |
| GND              | 7,19,32,42,<br>47,59,72,82 | 13,28,40,45,<br>61,76,88,97 | 11,26,38,43,<br>59,74,86,95 | 17,42,60,66,95,<br>113,138,148  |
| VCCINT           | 3,43                       | 41,93                       | 39,91                       | 61,143  |
| VCCIO            | 13,26,38,<br>53,66,78      | 5,20,36,53,68,84            | 3,18,34,51,66,82            | 8,26,55,79,104,133  |
| N/C              | —                          | —                           | —                           | 1,2,3,4,5,6,7,34,35,36,<br>37,38,39,40,44,45,46,<br>47,74,75,76,77,81,82,<br>83,84,85,86,87,114,<br>115,116,117,118,119,<br>120,124,125,126,127,<br>154,155,156,157 |
| # of SIGNAL PINS | 68                         | 84                          | 84                          | 100   |
| # USER I/O PINS  | 64                         | 80                          | 80                          | 96  |

|                    |   |
|--------------------|---|
| OE (1, 2)          | Global OE Pins  |
| GCLR               | Global Clear Pin  |
| GCLK (1, 2, 3)     | Global Clock Pins   |
| PD (1, 2)          | Power-down pins   |
| TDI, TMS, TCK, TDO | JTAG pins used for boundary scan testing or in-system programming |
| GND                | Ground Pins   |
| VCCINT             | VCC pins for the device (+5V - Internal)                          |
| VCCIO              | VCC pins for output drivers (for I/O pins) (+5V or 3.3V - I/Os)   |



## Package Information

### 84J – PLCC



10/04/01



2325 Orchard Parkway  
San Jose, CA 95131

#### TITLE

**84J**, 84-lead, Plastic J-leaded Chip Carrier (PLCC)

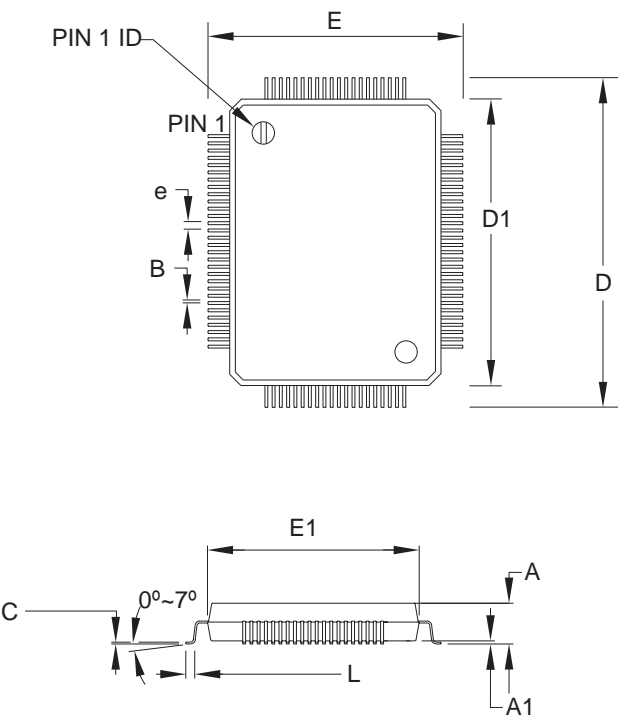
#### DRAWING NO.

84J

#### REV.

B

## 100Q1 – PQFP



**COMMON DIMENSIONS**  
(Unit of Measure = mm)  
JEDEC STANDARD MS-022, GC-1

| SYMBOL | MIN       | NOM  | MAX  | NOTE |
|--------|-----------|------|------|------|
| A      | –         | 3.04 | 3.4  |      |
| A1     | 0.25      | 0.33 | 0.5  |      |
| D      | 23.20 BSC |      |      |      |
| E      | 17.20 BSC |      |      |      |
| E1     | 14.00 BSC |      |      |      |
| B      | 0.22      | –    | 0.40 |      |
| C      | 0.11      | –    | 0.23 |      |
| D1     | 20 BSC    |      |      |      |
| L      | 0.73      | –    | 1.03 |      |
| e      | 0.65 BSC  |      |      |      |

07/6/2005



2325 Orchard Parkway  
San Jose, CA 95131

### TITLE

**100Q1**, 100-lead, 14 x 20 mm Body, 3.2 mm Footprint, 0.65 mm Pitch,  
Plastic Quad Flat Package (PQFP)

### DRAWING NO.

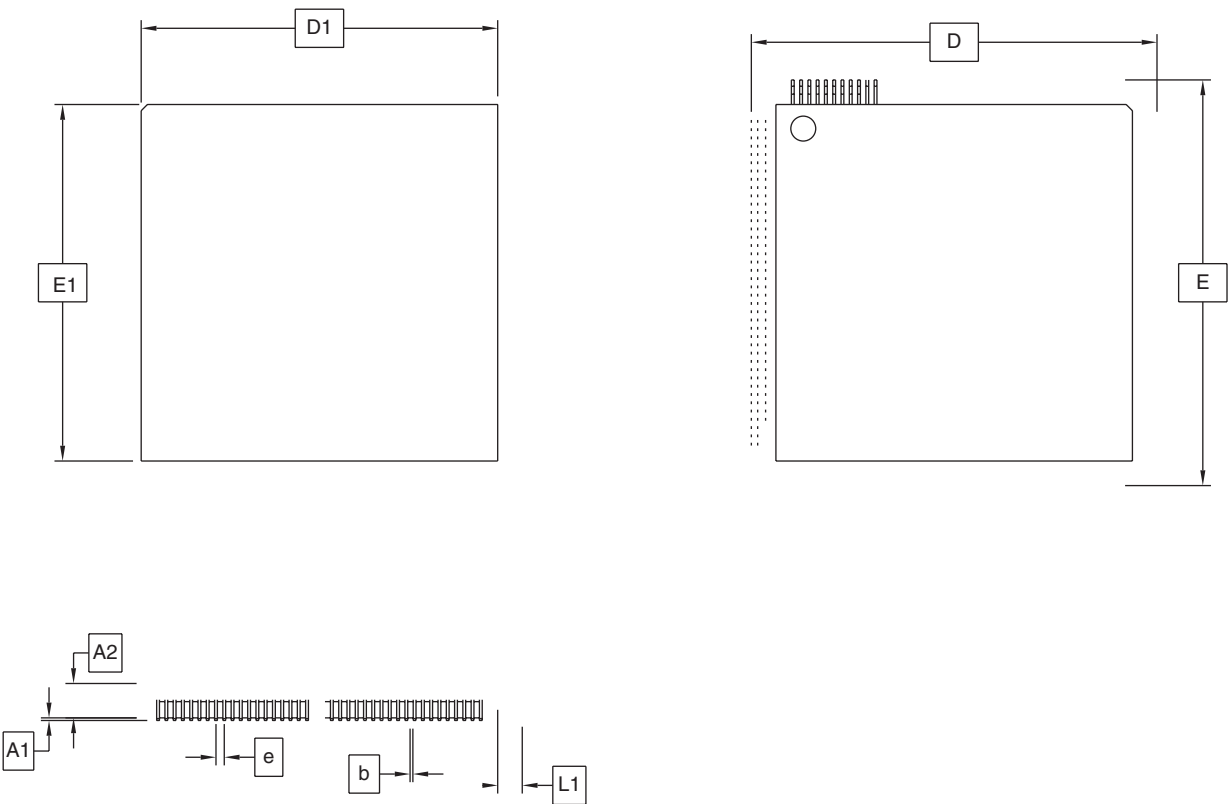
100Q1

### REV.


C



160Q1 – PQFP



3/28/02

|  |   |                             |                  |
|--|---|-----------------------------|------------------|
|  2325 Orchard Parkway<br>San Jose, CA 95131 | <b>TITLE</b><br><b>160Q1</b> , 160-lead, 28 x 28 mm Body, 3.2 Form Opt.,<br>Plastic Quad Flat Pack (PQFP) | <b>DRAWING NO.</b><br>160Q1 | <b>REV.</b><br>A |
|--|---|-----------------------------|------------------|



## Revision History

| Revision | Comments  |
|----------|---|
| 0784P    | Green package options added.  |
| 0784O    | The ATF1508ASL-25 commercial speed offering was obsoleted in 2002 and replaced by the ATF1508ASL-20 commercial speed grade. |



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